



Current issue date: 6 December 2023
Expiry date: 5 December 2026
Certificate identity number: 10567977

Original approval(s):
ISO/IEC 27001 - 6 December 2023

Certificate of Approval

This is to certify that the Management System of:

STATS ChipPAC Korea Ltd.

191, Jayumuyeok-ro, Jung-gu, Incheon 22379, Republic of Korea

has been approved by LRQA to the following standards:

ISO/IEC 27001:2022

Approval number(s): ISO/IEC 27001 – 00042504

This certificate is valid only in association with the certificate schedule bearing the same number on which the locations applicable to this approval are listed.

The scope of this approval is applicable to:

Information security management system for provision of Design, Manufacturing and associated testing of semiconductor products in accordance the Statement of Applicability version 1.0.

Il-Hyoung Lee

Korea Operations Manager

Issued by: LRQA Limited

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Issued by: LRQA Limited, 1 Trinity Park, Bickenhill Lane, Birmingham B37 7ES, United Kingdom



Certificate Schedule

Location	Activities
Plant 1 191, Jayumuyeok-ro, Jung-gu, Incheon 22379, Republic of Korea	ISO/IEC 27001:2022 Information security management system for provision of Design, Manufacturing and associated testing of semiconductor products in accordance the Statement of Applicability version 1.0.
Plant 2 299, Jayumuyeok-ro, Jung-gu, Incheon 22379, Republic of Korea	ISO/IEC 27001:2022 Information security management system for provision of Design, Manufacturing and associated testing of semiconductor products in accordance the Statement of Applicability version 1.0.